

Poster Presentation

MS67.P10

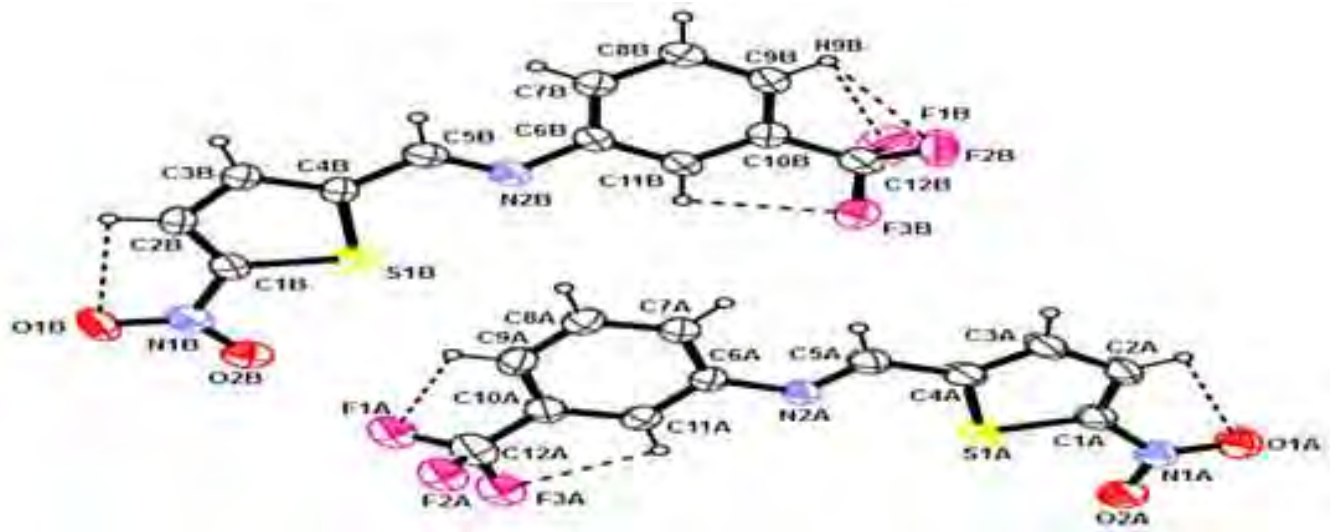
Structure of (E)-N-((5-Nitrothiophen-2-yl)Methylene)-3-(Trifluoromethyl)Aniline

Ö. Deveci¹, S. Gümüş², E. Açar²

¹Ondokuz Mayıs University, Department of Physics, Faculty of Arts and Sciences, Kurupelit, Turkey, ²Ondokuz Mayıs University, Department of Chemistry, Faculty of Arts and Science, Kurupelit, Turkey

The Schiff base compound, C₁₂H₇N₂O₂F₃S, has been synthesized and characterized by IR, UV-Vis, ¹H-NMR, ¹³C-NMR and single-crystal X-ray diffraction (XRD) and elemental analysis. The compound, an Ortep-3 [1] view of which is shown in Fig. 1, crystallizes in the monoclinic space group P-1 with a= 7.5700(11) Å, b= 12.8280(16) Å, c= 13.0170(16) Å, α= 89.295(10)°, β= 88.691(11)°, γ= 82.246(11)° and Z=4 in the unit cell. The molecular structure is stabilized by C-H...O and C-H...F intramolecular hydrogen bonds and molecules are linked through intermolecular C-H...O and C-H...F type hydrogen bonds and C-H...Cg (π-ring) interaction. The molecular geometry from X-ray determination of the title compound in the ground state has been compared using the Hartre-Fock (HF) and density functional theory (DFT/B3LYP) [2] with 6-31G(d) [3] basis set. The results of the optimized molecular structure are exhibited and compared with the experimental X-ray diffraction. To determine conformational flexibility, molecular energy profile of the title compound was obtained by B3LYP with the 6-31G(d) basis set calculations with respect to selected degree of torsional freedom, which was varied from -180° to +180° in steps of 10°. In addition, molecular electrostatic potential (MEP) distribution and frontier molecular orbitals (FMOs) properties of the title molecule were investigated by theoretical calculations at the B3LYP/6-31G(d) level. Figure 1. Ortep 3 diagram of the title compound. Displacement ellipsoids are drawn at the 30% probability level and H atoms are shown as small spheres of arbitrary radii.

[1] L.J. Farrugia, *J. Appl. Cryst.* 1997, 30, 565., [2] A.D. Becke, *J. Chem. Phys.* 1993, 98, 5648., [3] R. Ditchfield, W.J. Hehre, and J.A. Pople, *J. Chem. Phys.* 1971, 54, 724.



Keywords: X-ray diffraction, Hartree-Fock and DFT calculations, Schiff base